Attorney's Docket No. 5308-156

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

h re: Ryu et al. Serial No.: 09/911,995 Group Art Unit: 2811 Confirmation No.: 5240 Examiner: Gene Munson

Filed: July 24, 2001 For: SILICON C

SILICON CARBIDE POWER METAL-OXIDE SEMICONDUCTOR FIELD

EFFECT TRANSISTORS HAVING A SHORTING CHANNEL AND METHODS OF FABRICATING SILICON CARBIDE METAL-OXIDE SEMICONDUCTOR

FIELD EFFECT TRANSISTORS HAVING A SHORTING CHANNEL

Date: December 23, 2003

Mail Stop Fee Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Sir:

Attached is a list of documents on form PTO-1449 together with a copy of each identified document. It is requested that these documents be considered by the Examiner and officially made of record in accordance with the provisions of 37 C.F.R. § 1.56 and Section 609 of the MPEP.

This Information Disclosure Statement is submitted in accordance with 37 C.F.R. § 1.97(c), before final Office Action.

The Commissioner is authorized to charge the \$180.00 fee specified in 37 C.F.R. § 1.17(p). This amount is believed to be correct. However, the Commissioner is authorized to charge any deficiency or credit any overpayment to Deposit Account No. 50-0220.

Respectfully submitted,

Timothy J. O'Sullivan Registration No. 35,632

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I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to: Mail Stop Fee Amendment, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on December 23, 2003.

Rosa Lee Brinson

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	1.	5,587,870	12/24/96	Anderson et al.		361	313			
	2.	5,877,045	3/2/99	Kapoor		438	151			
	3.	6,136,728	10/24/00	Wang		438	773	,		
	4.	6,063,698	05/16/00	Tseng et al. Gardner et al. Wang		438	585			
	5.	6,048,766	04/11/00			438	257			
	6.	6,028,012	02/22/00			438	779			
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	7.	WO99/63591	12/09/99							
	8.	WO00/13236	03/09/00	PCT						
		OTHER DOC	CUMENTS (II	ncluding Author	, Title, Date, Per	rtinent Pages,	Etc.)			
	9. Mutin, P. Herbert, "Control of the Composition and Structure of Silicon Oxycarbide and Oxynitride Glasses Derived from Polysiloxane Precursors," <i>Journal of Sol-Gel Science and Technology</i> . Vol. 14 (1999) pp. 27-38.									
	10.	del Prado et al. "Full Composition Range Silicon Oxynitride Films Deposited by ECR-PECVD at Room Temperatures," <i>Thin Solid Films</i> . Vol. 343-344 (1999) p. 437-440.								
	11.	Wang et al. "High Temperature Characteristics of High-Quality SiC MIS Capacitors with O/N/O Gate Dielectric," <i>IEEE Transactions on Electron Devices</i> . Vol. 47, No. 2, February 2000.								
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DATE CONSIDERED

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	7.	WO99/63591	12/09/99	PCT	-				
	8.	WO00/13236	03/09/00	PCT					
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1		OTHER DOC	CUMENTS (In	cluding Author,	Title, Date, Per	rtinent Pages,	Etc.)		
X	9.	Mutin, P. Herber Glasses Derived (1999) pp. 27-38	from Polysilox	the Composition kane Precursors,	and Structure of So	of Silicon Ox <i>l-Gel Science</i>	ycarbide and (and Technology	Oxynitride ogy. Vol. 14	
	10.	del Prado et al. "Full Composition Range Silicon Oxynitride Films Deposited by ECR-PECVD at Room Temperatures," <i>Thin Solid Films</i> . Vol. 343-344 (1999) p. 437-440.							
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